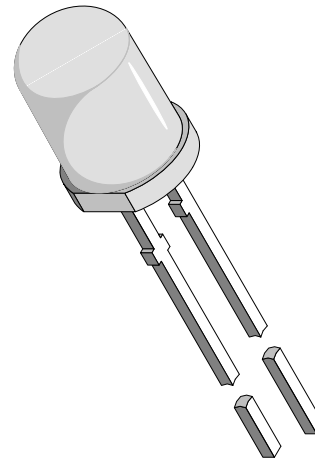

GaAs Infrared Emitting Diodes in \varnothing 5 mm (T-1 $\frac{3}{4}$) Package

Description

TSUS 520. series are infrared emitting diodes in standard GaAs on GaAs technology, molded in a clear, blue-grey tinted plastic package. The devices are spectrally matched to silicon photodiodes and phototransistors.



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Features

- Low cost emitter
- Low forward voltage
- High radiant power and radiant intensity
- Suitable for DC and high pulse current operation
- Standard T-1 $\frac{3}{4}$ (\varnothing 5 mm) package
- Angle of half intensity $\varphi = \pm 15^\circ$
- Peak wavelength $\lambda_p = 950$ nm
- High reliability
- Good spectral matching to Si photodetectors

Applications

Infrared remote control and free air transmission systems with low forward voltage and low cost requirements in combination with PIN photodiodes or phototransistors.

Absolute Maximum Ratings

 $T_{amb} = 25^{\circ}\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Reverse Voltage		V_R	5	V
Forward Current		I_F	150	mA
Peak Forward Current	$t_p/T=0.5, t_p=100\ \mu\text{s}$	I_{FM}	300	mA
Surge Forward Current	$t_p=100\ \mu\text{s}$	I_{FSM}	2.5	A
Power Dissipation		P_V	210	mW
Junction Temperature		T_j	100	$^{\circ}\text{C}$
Operating Temperature Range		T_{amb}	-55...+100	$^{\circ}\text{C}$
Storage Temperature Range		T_{stg}	-55...+100	$^{\circ}\text{C}$
Soldering Temperature	$t \leq 5\text{sec}, 2\ \text{mm from case}$	T_{sd}	260	$^{\circ}\text{C}$
Thermal Resistance Junction/Ambient		R_{thJA}	375	K/W

Basic Characteristics

 $T_{amb} = 25^{\circ}\text{C}$

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Forward Voltage	$I_F = 100\ \text{mA}, t_p = 20\ \text{ms}$	V_F		1.3	1.7	V
Temp. Coefficient of V_F	$I_F = 100\ \text{mA}$	TK_{VF}		-1.3		mV/K
Reverse Current	$V_R = 5\ \text{V}$	I_R			100	μA
Junction Capacitance	$V_R = 0\ \text{V}, f = 1\ \text{MHz}, E = 0$	C_j		30		pF
Temp. Coefficient of ϕ_e	$I_F = 20\ \text{mA}$	TK_{ϕ_e}		-0.8		%/K
Angle of Half Intensity		ϕ		± 15		deg
Peak Wavelength	$I_F = 100\ \text{mA}$	λ_p		950		nm
Spectral Bandwidth	$I_F = 100\ \text{mA}$	$\Delta\lambda$		50		nm
Temp. Coefficient of λ_p	$I_F = 100\ \text{mA}$	TK_{λ_p}		0.2		nm/K
Rise Time	$I_F = 100\ \text{mA}$	t_r		800		ns
Rise Time	$I_F = 1.5\ \text{A}$	t_r		400		ns
Fall Time	$I_F = 100\ \text{mA}$	t_f		800		ns
Fall Time	$I_F = 1.5\ \text{A}$	t_f		400		ns

Type Dedicated Characteristics

$T_{amb} = 25^{\circ}\text{C}$

Parameter	Type	Test Conditions	Symbol	Min	Typ	Max	Unit
Forward Voltage	TSUS5200/5201	$I_F=1.5\text{A}$, $t_p=100\mu\text{s}$	V_F		2.2	3.4	V
	TSUS5202	$I_F=1.5\text{A}$, $t_p=100\mu\text{s}$	V_F		2.2	2.7	V
Radiant Intensity	TSUS5200	$I_F=100\text{mA}$, $t_p=20\text{ms}$	I_e	10	20		mW/sr
	TSUS5201	$I_F=100\text{mA}$, $t_p=20\text{ms}$	I_e	15	25		mW/sr
	TSUS5202	$I_F=100\text{mA}$, $t_p=20\text{ms}$	I_e	20	30		mW/sr
Radiant Intensity	TSUS5201	$I_F=1.5\text{A}$, $t_p=100\mu\text{s}$	I_e	120	230		mW/sr
	TSUS5200	$I_F=1.5\text{A}$, $t_p=100\mu\text{s}$	I_e	95	180		mW/sr
	TSUS5202	$I_F=1.5\text{A}$, $t_p=100\mu\text{s}$	I_e	170	280		mW/sr
Radiant Power	TSUS5200	$I_F=100\text{mA}$, $t_p=20\text{ms}$	ϕ_e		13		mW
	TSUS5201	$I_F=100\text{mA}$, $t_p=20\text{ms}$	ϕ_e		14		mW
	TSUS5202	$I_F=100\text{mA}$, $t_p=20\text{ms}$	ϕ_e		15		mW

Typical Characteristics ($T_{amb} = 25^{\circ}\text{C}$ unless otherwise specified)

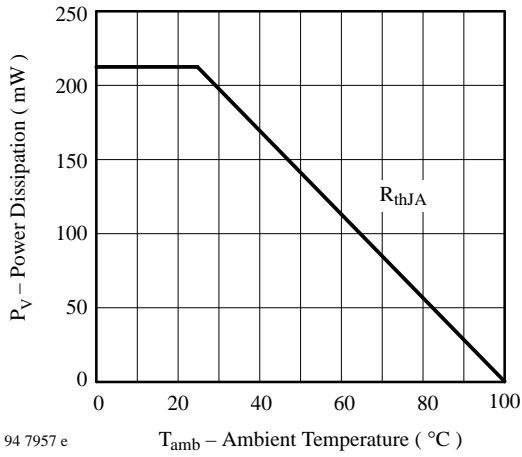


Figure 1 : Power Dissipation vs. Ambient Temperature

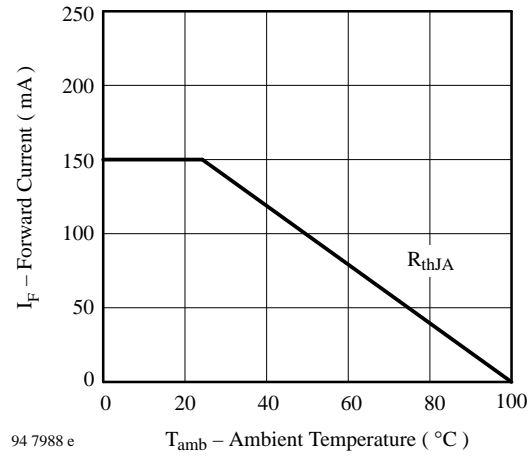


Figure 2 : Forward Current vs. Ambient Temperature

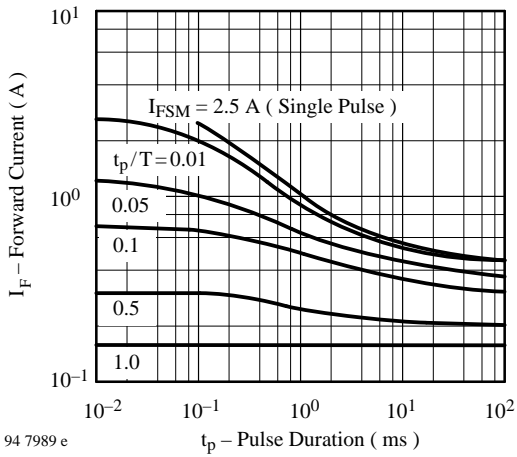


Figure 3 : Pulse Forward Current vs. Pulse Duration

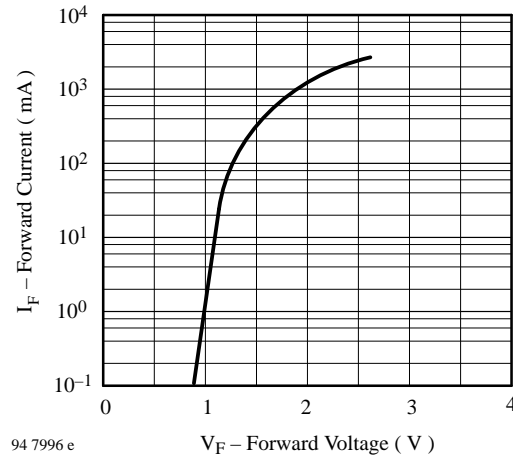


Figure 4 : Forward Current vs. Forward Voltage



Figure 5 : Relative Forward Voltage vs. Ambient Temperature

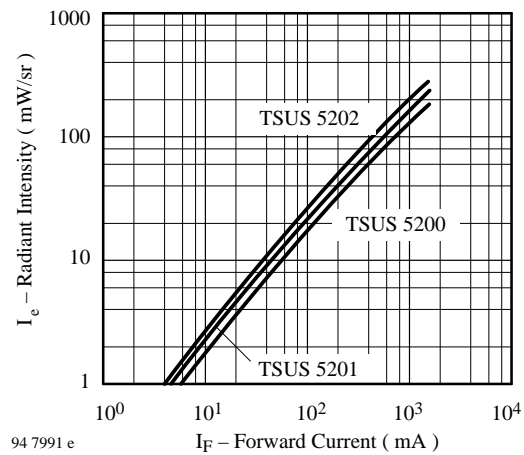


Figure 6 : Radiant Intensity vs. Forward Current

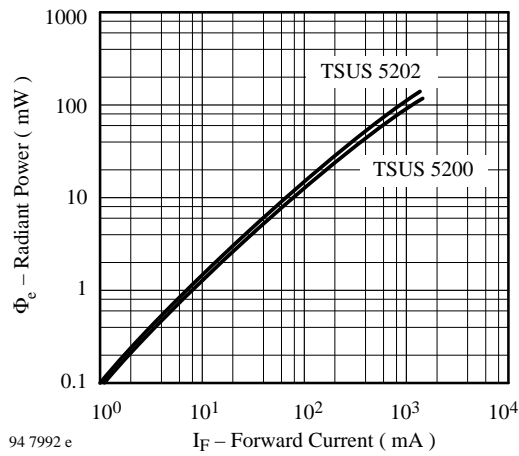


Figure 7 : Radiant Power vs. Forward Current

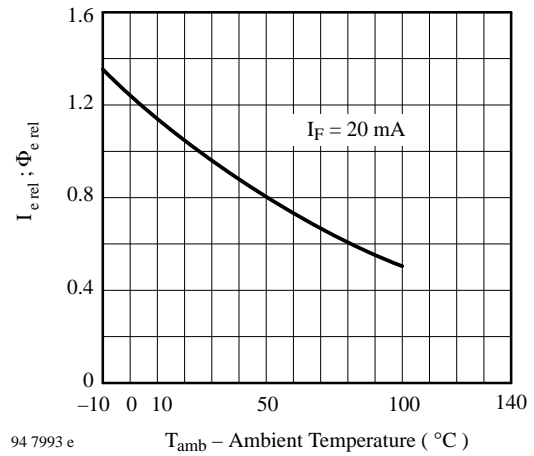


Figure 8 : Rel. Radiant Intensity/Power vs. Ambient Temperature

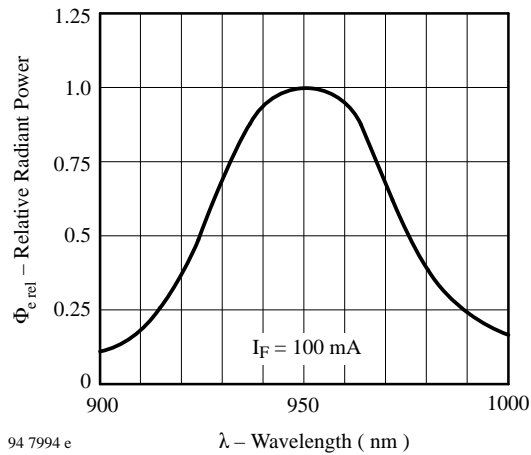


Figure 9 : Relative Radiant Power vs. Wavelength

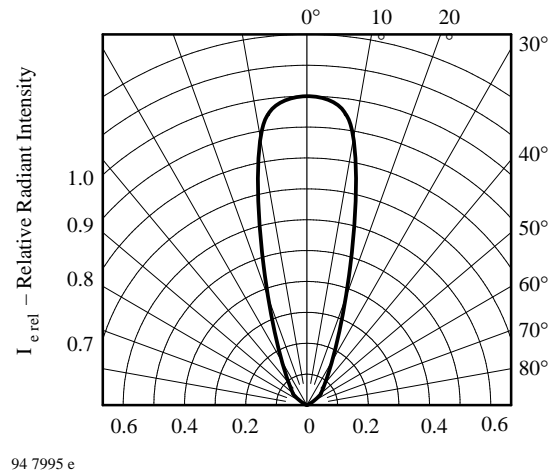


Figure 10 : Relative Radiant Intensity vs. Angular Displacement

